Special Issue

Optical Chirality: Structures, Detection and Applications

Message from the Guest Editors

Chirality at the nanoscale can be found in nanostructures of both intrinsic and extrinsic nature, and it is of great interest for applications spanning from chiral sensing to spin-dependent and circularly polarized sources. Design and investigation of new structures, their properties, and the schemes for detection of chiral response are hot topics in the optics and nanophotonics community today. Papers on these arguments are solicited. Keywords

- Chirality
- Nanophotonics
- Nanomaterials
- Circular Dichroism
- Optical Methods

Guest Editors

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Deadline for manuscript submissions

closed (10 November 2021)



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Message from the Editor-in-Chief

As the world of science becomes ever more specialized, researchers may lose themselves in the deep forest of the ever increasing number of subfields being created. This open access journal *Applied Sciences* has been started to link these subfields, so researchers can cut through the forest and see the surrounding, or quite distant fields and subfields to help develop his/her own research even further with the aid of this multi-dimensional network.

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